



Sheet 1 of 2

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 122698		APPLICATION NO. 10/523,921	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hidetoshi KUSUMI			
				FILING DATE February 7, 2005		GROUP 2834	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
	1	US 5,694,313	12/2/1997	Ooiwa			
	2	US 5,705,902	01/6/1998	Merritt et al.			
	3	US 6,002,219	12/14/1999	Permuy			
	4	US 6,713,888-B2	03/30/2004	Kajiura			
	5	US 6,725,821-B2	04/27/2004	Warren et al.			
	6	US 6,806,671-B2	10/19/2004	Kusaka et al.			
	7	US 6,882,047-B2	04/19/2005	Hata et al.			
	8	US 2006/0087181-A1	04/27/2006	Kusumi			
	9	US 6,538,352-B2	03/25/2003	Asao			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	10	JP-A-06-062553	03/04/1994	JAPAN	X	X	
	11	JP-U-03-111184	11/14/1991	JAPAN	X		
	12	JP-A-56-081069	07/02/1981	JAPAN	X		
	13	JP-A-04-011757	01/16/1992	JAPAN	X		
	14	JP-A-05-067889	03/19/1993	JAPAN	X	X	
	15	JP-A-2001-270401	10/02/2001	JAPAN	X	X	
	16	JP-A-2001-268924	09/28/2001	JAPAN	X	X	
	17	JP-A-11-235051	08/27/1999	JAPAN	X	X	
	18	JP-A-2002-153030	05/24/2002	JAPAN	X	X	
	19	JP-A-08-084439	03/26/1996	JAPAN	X	X	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER /Thanh Lam/ (03/26/2008)				DATE CONSIDERED			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: November 30, 2007

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /TL/

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	20	JP-A-11-284122	10/15/1999	JAPAN	X	X	
	21	JP-A-09-143649	06/03/1997	JAPAN	X	X	
	22	JP-A-10-056762	02/24/1998	JAPAN	X	X	
	23	JP-A-61-240666	10/25/1986	JAPAN	X		
OTHER DOCUMENTS							
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